Form PTO 1449		U.S. DEPARTMEN	T OF COMMERCE	ATTY DOCKET NO.		SERIAL NO).	
Form PTO 1449 U.S. DEPARTMENT OF COMMERC (Modified) PATENT AND TRADEMARK OFFICE			ADEMARK OFFICE	244839US3DIV		New Application		
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT				
				Daisaku KUROKAWA, et al.				
				FILING DATE		GROUP		
				Herewith		New Application		
				U.S. PATENT DOCUMENTS				
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	AC	4,129,029	12/78	Moll et al				
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	Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEF					Date Considered 4/28/04		
⊏xaminer: Ini conformance a	ual if re and no	erence is considéred, t considered. Include a	whether or not	citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lin	e through cita	ation if not in	
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